

PATENT

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

**Present Application:**

Applicants: Douglas D. Do and Jeff C. Johnson  
Attorney Docket No.: 500414.02  
Date : July 31, 2000  
Title : METHOD AND APPARATUS FOR MEASURING FEATURES OF A  
SEMICONDUCTOR DEVICE

**Prior Application:**

Examiner : Craig Thompson  
Art Unit : 2813  
Serial No. : 09/083,835

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**PRELIMINARY AMENDMENT**

Box Patent Application  
Assistant Commissioner of Patents  
Washington, D.C. 20231

Sir:

Prior to substantive examination, please amend the above-identified application as follows:

**In the Title:**

Amend the title of the application to read --APPARATUS FOR MEASURING FEATURES OF A SEMICONDUCTOR DEVICE-- in each place where it appears

**In the Specification:**

Amend the specification by inserting a new section before the "Technical Field" as follows: